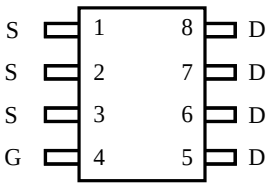
P -Channel High Density Trench MOSFET

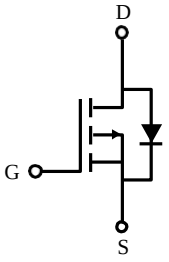
Features:

- Super high dense cell trench design for low $R_{DS(on)}$.
- Rugged and reliable.
- Improved Shoot-Though FOM.
- Surface Mount package.

SOP-8



PRODUCT SUMMARY		
V_{DSS}	I_D	$R_{DS(on)}$ (mΩ) Max
-60V	- 6.5A	75 @ V_{GS} = -10V
	- 4.2A	93 @ V_{GS} = -4.5V



Ordering Information

KSC6063□P

- Package Type : SOP-8
- F : Pb Free
- G : Green (Halogen Free)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	- 60	V
Gate-Source Voltage		V_{GS}	± 20	V
Drain Current-Continuous[a] @ T_A = 25 ℃		I_D	- 6.5	A
-Pulse[b]		I_{DM}	- 25	A
Drain-Source Diode Forward Current[a]		I_S	- 3.6	A
Maximum Power Dissipation[a]	TA=25℃	P_D	2.5	W
	TA=75℃		1.5	
Operating Junction and Storage Temperature Range		T_J,T_{STG}	- 55 to 150	℃

THERMAL CHARACTERISTICS

Thermal Resistance,Junction-to-Ambient[a]	R_{thJA}	50	℃/W

Note:
a. Surface Mounted on FR4 Board , t ≤ 10sec .
b. Pulse width limited by maximum junction temperature .

ELECTRICAL CHARACTERISTICS (T_A = 25 ℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ[c]	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0V , I_D = -250uA	-60			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = -48V , V_{GS} = 0V			-10	uA
Gate-Body Leakage	I_{GSS}	V_{GS} = -20V , V_{DS} = 0V			-100	nA
ON CHARACTERISTICS[b]						
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS} , I_D = -250uA	-1	-1.6	-3	V
Drain-Source On-State Resistance	$R_{DS(on)}$	V_{GS} = -10V , I_D = -6.5A		55	75	mΩ
		V_{GS} = -4.5V , I_D = -4.2A		70	93	mΩ
Forward Transconductance	g_{fs}	V_{DS} = -15V , I_D = -4.6A		10		S
DRAIN-SOURCE DIODE CHARACTERISTICS[b]						
Diode Forward Voltage	V_{SD}	V_{GS} = 0V , I_S = -5.3A			-1.3	V
DYNAMIC CHARACTERISTICS[c]						
Input Capacitance	C_{ISS}	V_{DS} = -30V , V_{GS} = 0V f = 1.0MHz		456		pF
Output Capacitance	C_{OSS}			62		pF
Reverse Transfer Capacitance	C_{RSS}			35		pF
SWITCHING CHARACTERISTICS[c]						
Turn-On Delay Time	$t_{D(ON)}$	V_{DD} = -30V , I_D = -3A V_{GEN} = -10V R_L = 5 Ω R_{GEN} = 6 Ω		8.2		ns
Rise Time	t_r			2.6		ns
Turn-Off Delay Time	$t_{D(OFF)}$			21.7		ns
Fall Time	t_f			4.7		ns
Total Gate Charge	Q_g	V_{DS} = -30V I_D = -3A V_{GS} = -10V		9		nC
Gate-Source Charge	Q_{gs}			1.7		nC
Gate-Drain Charge	Q_{gd}			1.1		nC

Note:
b. Pulse Test: Pulse width ≤ 300us , Duty Cycle ≤ 2% .
c. Guaranteed by design , not subject to production testing .

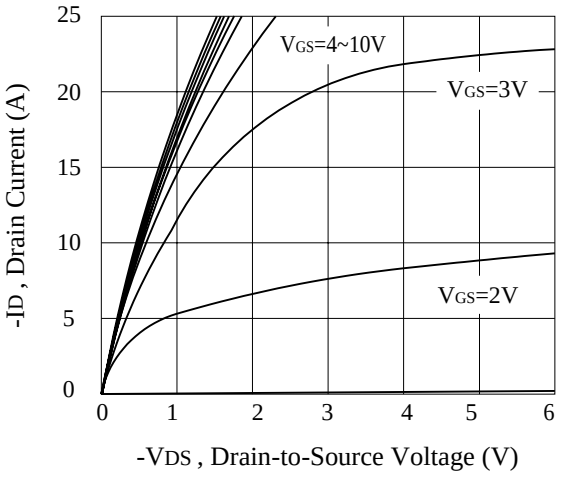


Figure 1. Output Characteristics

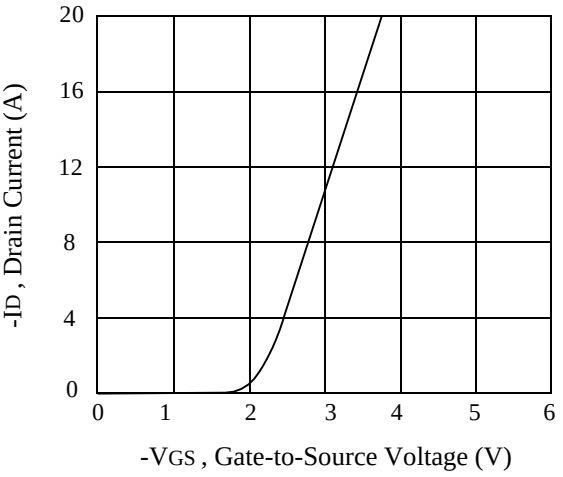


Figure 2. Transfer Characteristics

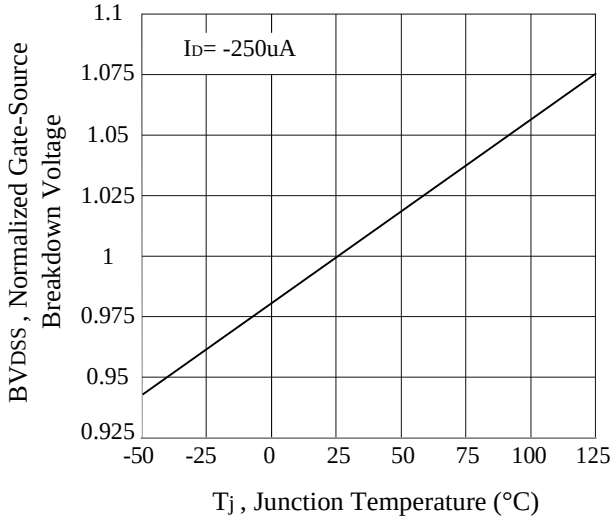


Figure 3. Breakdown Voltage Variation with Temperature

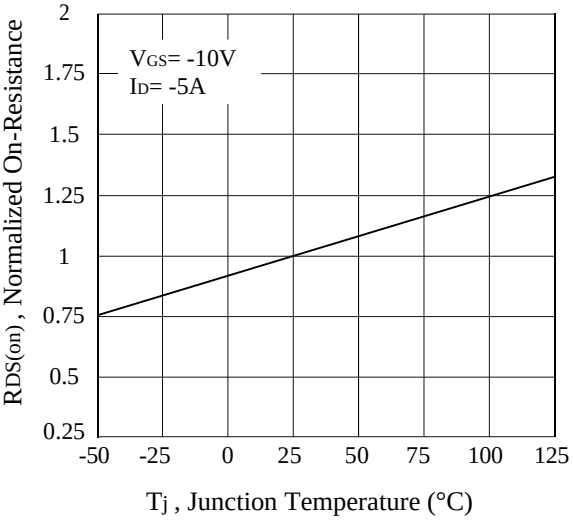


Figure 4. On-Resistance Variation with Temperature

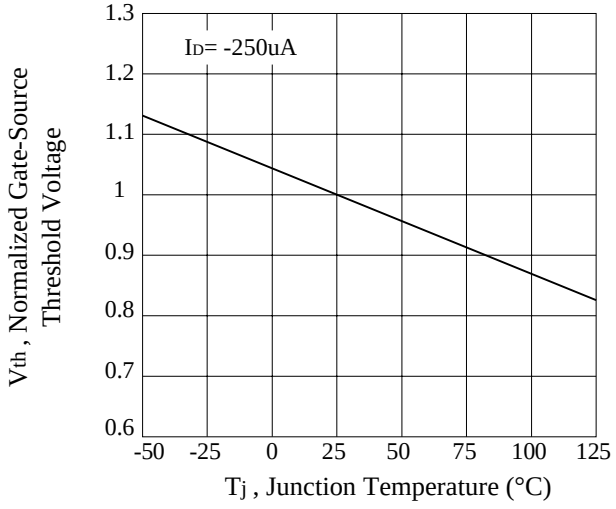


Figure 5. Gate Threshold Variation with Temperature

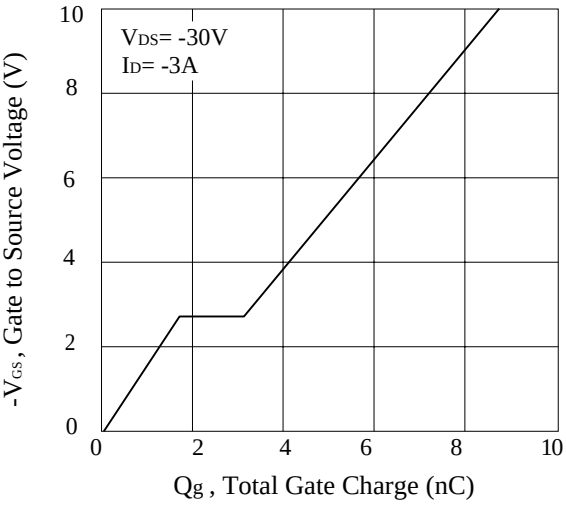
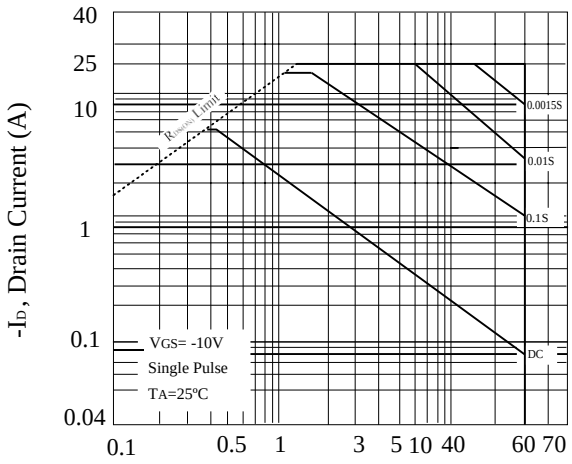
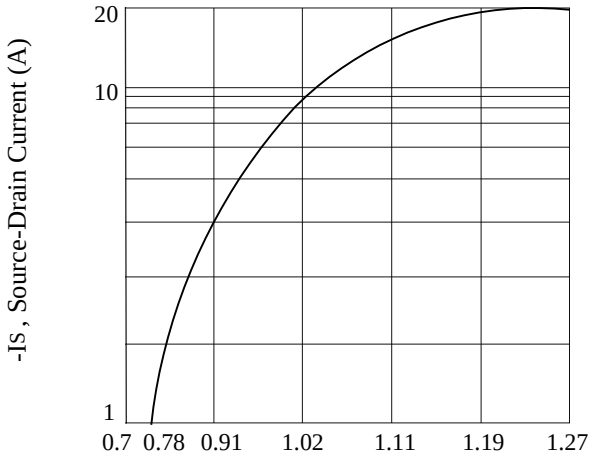


Figure 6. Gate Charge



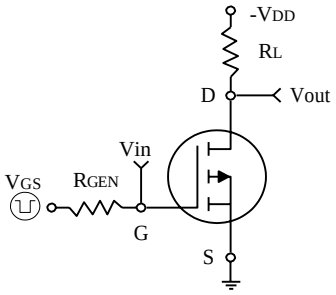
-VDS , Drain-Source Voltage (V)

Figure 7. Maximum Safe Operating Area



-VSD , Body Diode Forward Voltage (V)

Figure 8. Body Diode Forward Voltage Variation with Source Current



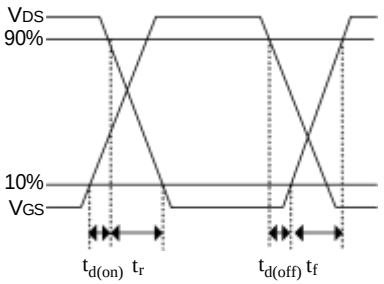
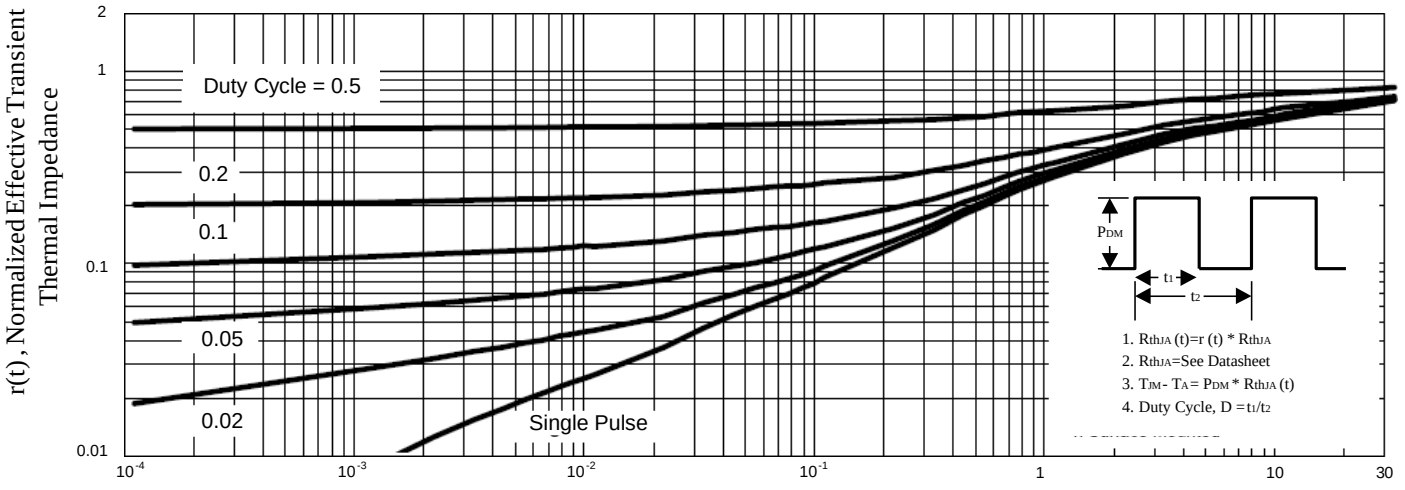


Figure 9. Switching Test Circuit and Switching Waveforms



Square Wave Pulse Duration (sec)

Figure 10. Normalized Thermal Transient Impedance Curve